

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/539,637	LAM ET AL.	
Examiner	Art Unit	
Kimbinh T. Nguyen	2671	

	SEARCHED				
Class	Subclass	Date	Examiner		
345	545	10/11/2005	KN		
345	546	10/11/2005	KN		
345	547	10/11/2005	KN		
345	548	10/11/2005	KN		
345	543	10/11/2005	KN		
345	544	10/11/2005	KN		
345	558	10/11/2005	KN		
345	560	10/11/2005	KN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
345	546	10/11/2005	KN	
346	·558	10/11/2005	KN	
345	560	10/11/2005	KN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor names	10/11/2005	KN		
EAST: classification	10/11/2005	KN		
WEST: text search	10/11/2005	KN		
NPL: ACM, IEEE	10/11/2005	KN		